

Notice of References Cited		Application/Control No. 10/006,180	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
		Examiner Alonzo Chambliss	Art Unit 2827	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,452,256	09-2002	Kazama et al.	257/668
	B	US-6,117,299	09-2000	Rinne et al.	205/125
	C	US-6,518,675	02-2003	Kim et al.	257/773
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 877419 A2	11-1998	European Patent	RINNE et al.	H01L 21/60
	O	JP 02271635 A	11-1990	Japan	MURAKAMI, HIROAKI	H01L 21/321
	P	JP 01209746 A	08-1989	Japan	MORIYAMA, YOSHIFUMI	H01L 21/92
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.